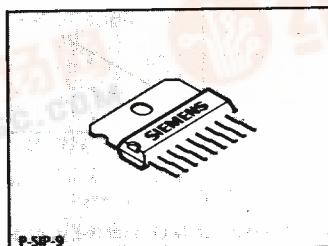
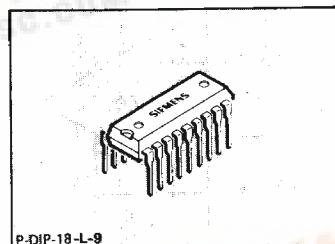


Dual Power Operational Amplifier**TCA 2365****Features**

- High output peak current of twice 2.5 A
- Wide supply voltage range, 8 V to 32 V
- High slew rate 4 V/ μ s
- Outputs entirely protected (DC short-circuit proof)
- Thermal overload protection
- Inhibit input enables "tristate" outputs

Applications

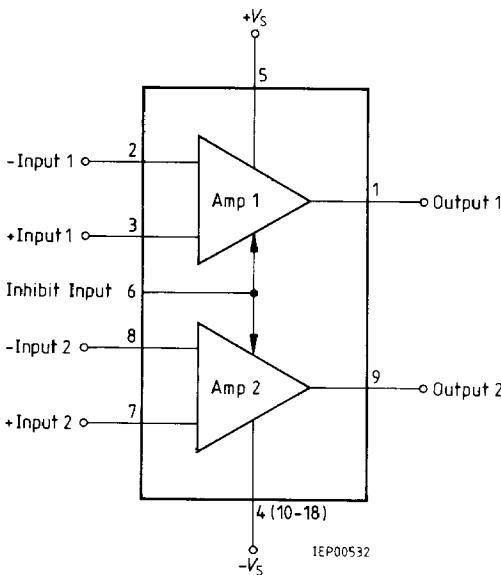
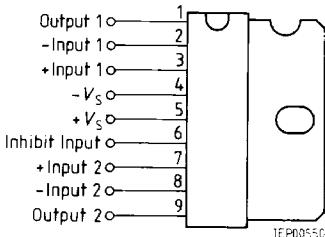
- Power comparator
- Power Schmitt trigger
- Speed control of DC motors

Bipolar IC

Type	Ordering Code	Package
TCA 2365	Q67000-A1876	P-SIP-9
TCA 2365 A	Q67000-A8017	P-DIP-18-L-9

The TCA 2365 is a dual power op amp in a P-SIP-9 or P-DIP-18L-9 package. The IC contains two identical op amps, each supplying a high output peak current of 2.5 A at supply voltages between ± 4 V and ± 15 V. Both amplifiers can be disconnected simultaneously (tristate; $Z_Q \approx 4$ k Ω) via an inhibit input. Integrated protective circuits protect the outputs against short circuit to $+V_S$ and $-V_S$ and prevent thermal overloading of the IC.

Pin Configuration
TCA 2365A

**TCA 2365****Absolute Maximum Ratings**

Parameter	Symbol	Limit Values		Unit
		TCA 2365	TCA 2365A	
Supply voltage $t = 50 \text{ ms}$	V_S $V_{S\text{ }}$	± 16 ± 18	± 16 ± 18	V V
Differential input voltage	V_{ID}	$\pm V_S$	$\pm V_S$	V
Output voltage range	V_Q	$-V_S - 1 \text{ to } +V_S + 1$	$+V_S + 1$	V
Peak output current	I_Q	± 2.5	± 2.5	A
Supply current	I_S	5.5	5.5	A
Junction temperature	T_j	150	150	$^{\circ}\text{C}$
Storage temperature range	T_{stg}	-55 to 125	-55 to 125	$^{\circ}\text{C}$
Thermal resistance junction – ambient	$R_{th\ jA}$	65	60	K/W
junction – case	$R_{th\ jC}$	6	10	K/W

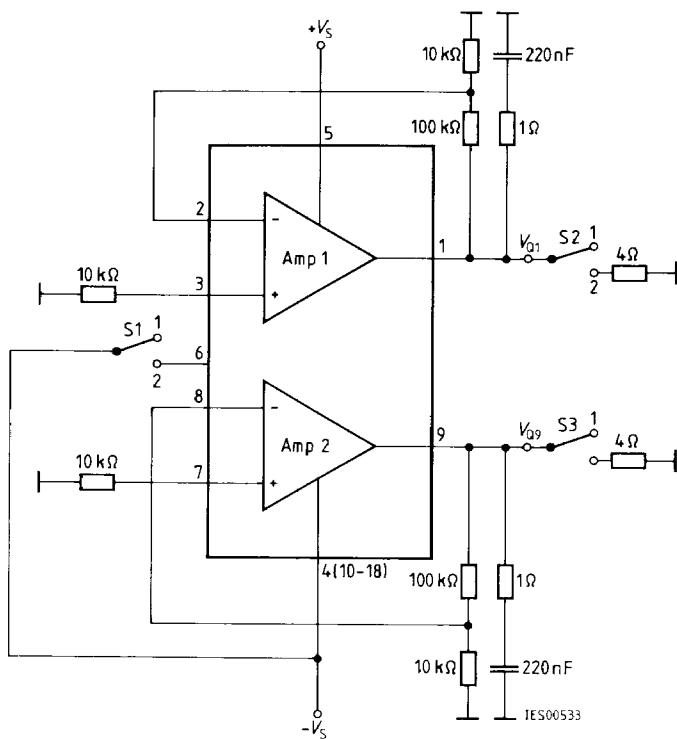
Operating Range

Supply voltage	V_S	$\pm 4 \text{ to } \pm 15$	$\pm 4 \text{ to } \pm 15$	V
Case temperature $P_{tot} = 10.0 \text{ W}$	T_C	-25 to 85	-25 to 85	$^{\circ}\text{C}$
Voltage gain	$G_V \text{ min}$	10	10	dB

Characteristics $V_S = \pm 10 \text{ V}$; $T_J = 25^\circ\text{C}$

Parameter	Symbol	Limit Values			Unit	Test Circuit
		min.	typ.	max.		
Open-loop supply current consumption S1 in position 1 S1 in position 2	I_S I_{SM}		30 5	50 8	mA mA	1 1
Input offset voltage	V_{IO}	-10		10	mV	2
Input offset current	I_{IO}	-100		100	nA	3
Input current	I_I		0.25	1	μA	3
Output voltage ($R_L = 12 \Omega$; $f = 1 \text{ kHz}$) ($R_L = 4 \Omega$; $f = 1 \text{ kHz}$) ($R_L = 470 \Omega$; $f = 50 \text{ kHz}$)	$V_{O \text{ pp}}$ $V_{O \text{ pp}}$ $V_{O \text{ pp}}$	± 8.5 ± 8.0	± 9.0 ± 8.5 ± 6.0		V V V	4 4 4
Input resistance ($f = 1 \text{ kHz}$)	R_I	1	5		$\text{M}\Omega$	4
Open-loop voltage gain ($f = 100 \text{ Hz}$)	G_{V0}	70	80		dB	5
Common-mode input voltage range	V_{IC}	+7/-10	+7.5/-10.5		V	6
Common-mode rejection Supply voltage rejection	K_{CMR} K_{SVR}	70 70	80 80		dB dB	6 7
Temperature coefficient of V_{IO} $-25^\circ\text{C} \leq T_J \leq +85^\circ\text{C}$	α_{VIO}		50		$\mu\text{V/K}$	2
Temperature coefficient of I_{IO} $-25^\circ\text{C} \leq T_J \leq +85^\circ\text{C}$	α_{IIO}		0.4		nA/K	3
Slew rate of V_q for non-inverting operation ¹⁾	SR		4		$\text{V}/\mu\text{s}$	8
Slew rate of V_q for inverting operation ¹⁾	SR		4		$\text{V}/\mu\text{s}$	9
Noise voltage referred to input Inhibit input (referred to $-V_S$)	V_n		3		μV	1
V_6 for IC turned off V_6 for IC turned on	$V_{6 \text{ OFF}}$ $V_{6 \text{ ON}}$	0 3.0		1.0 6	V V	1 1
Turn-on time $ I_{I_{1,9}} > 1 \text{ A}$ Turn-off time $ I_{I_{1,9}} < 1 \text{ A}$ S2 and S3 in position 2	$t_{D \text{ ON}}$ $t_{D \text{ OFF}}$		2 15	5 30	μs	1 1

¹⁾ For the relationship between power bandwidth and slew rate refer to "General Information"

Test Circuits**Figure 1****Open-Loop Supply Current Consumption, Noise Voltage, Turn-Off Voltage**

Switch as drawn unless otherwise specified.

Figure 2
Input Offset Voltage, Temperature Coefficient of V_{IO}

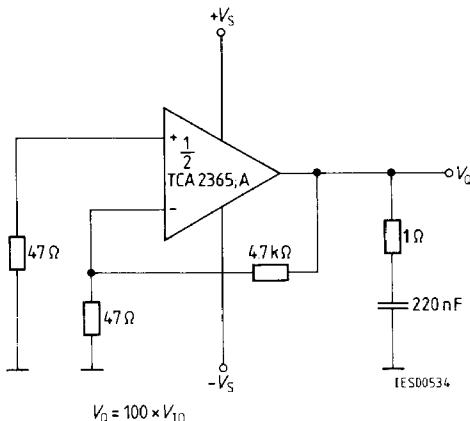
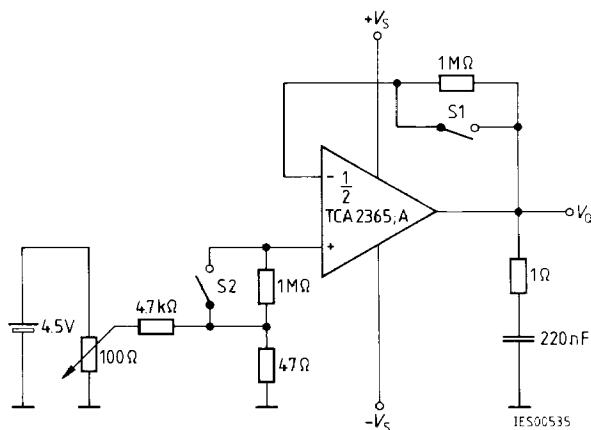


Figure 3
Input Offset Current, Input Current, Temperature Coefficient of I_{IO}



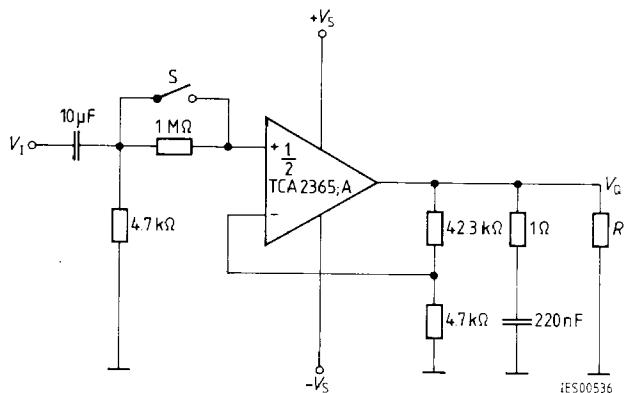
$$\text{S1 open} - \text{S2 closed: } I_{I-} = \frac{V_Q}{1 \text{ M}\Omega}$$

$$\text{S2 open} - \text{S1 closed: } I_{I+} = \frac{V_Q}{1 \text{ M}\Omega}$$

$$\text{S1 open} - \text{S2 open: } I_{IO} = \frac{V_Q}{1 \text{ M}\Omega}$$

S1 closed – S2 closed: offset alignment

Figure 4
Output Voltage, Input Resistance



S closed : to measure $V_{O_{PP}}$
 S open/closed : to measure R_I

Figure 5
Open-Loop Voltage Gain

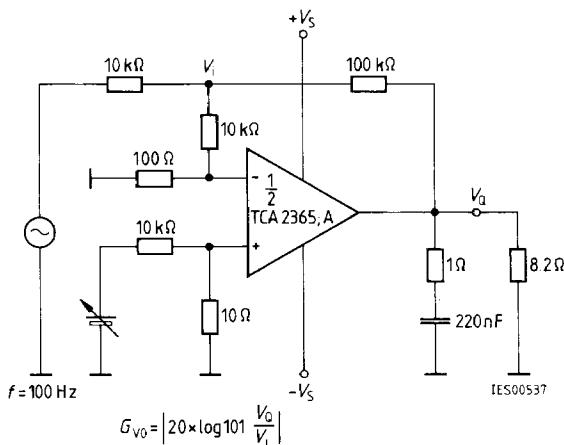
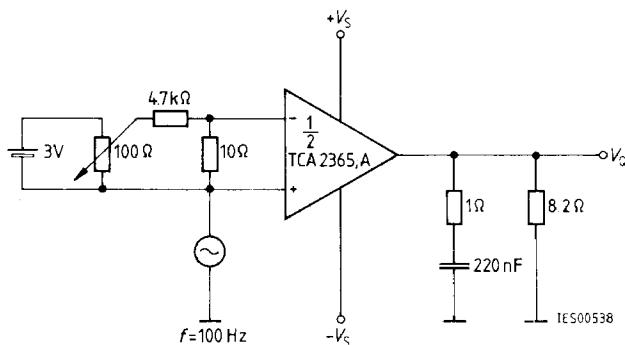
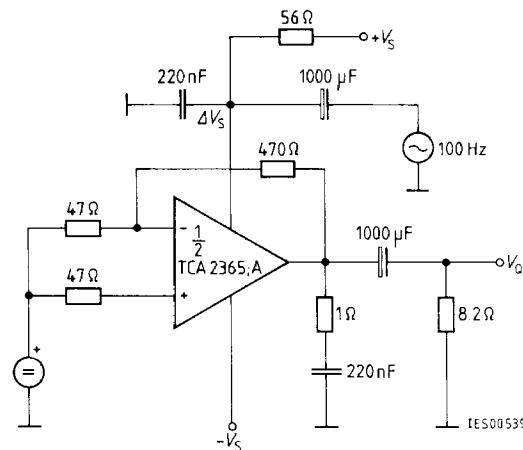


Figure 6**Common-Mode Voltage Gain G_{VC}** **Common-Mode Rejection k_{CMR} (dB) = G_{V0} (dB) - G_{VC} (dB)****Figure 7****Supply Voltage Rejection**

$$k_{SVR} = 20 \log \frac{\Delta V_0}{G_V \cdot \Delta V_S} \text{ [dB]}$$

Figure 8
Slew Rate for Non-Inverting Operation

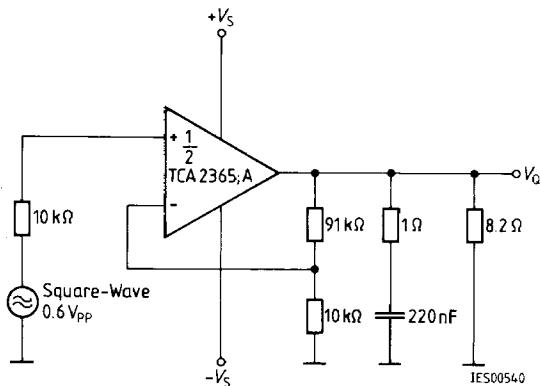
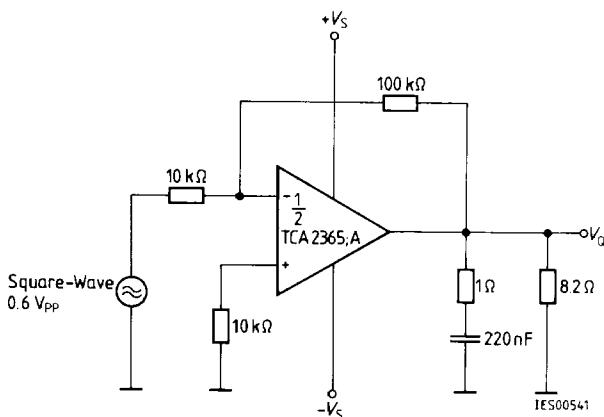
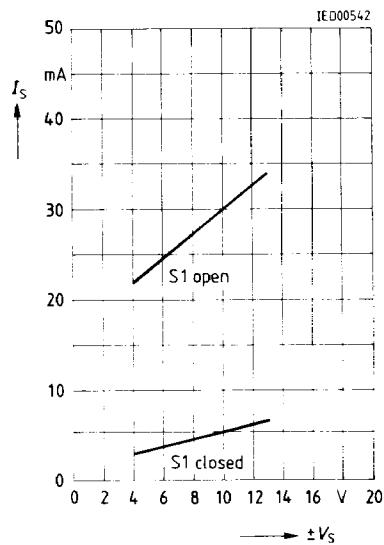


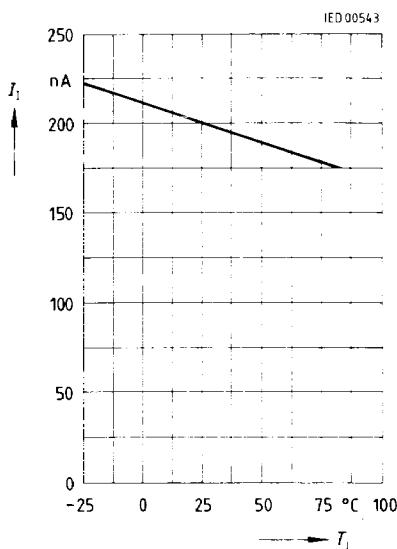
Figure 9
Slew Rate for Inverting Operation



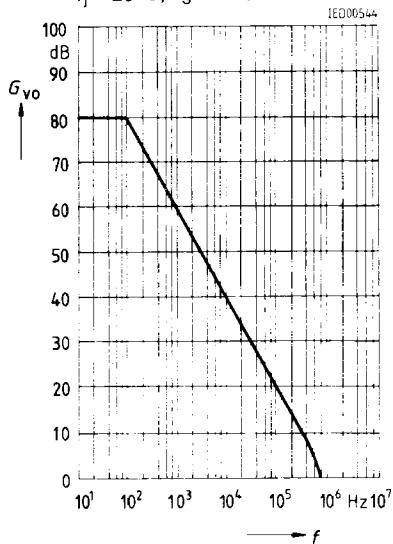
Supply Current I_S and I_{SM} versus Supply Voltage
 $T_j = 25^\circ\text{C}$



Input Current versus Junction Temperature

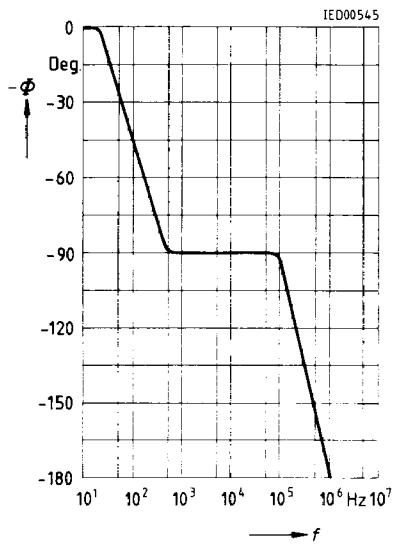


Open-Loop Voltage Gain versus Frequency
 $T_j = 25^\circ\text{C}; V_S = \pm 10\text{ V}$



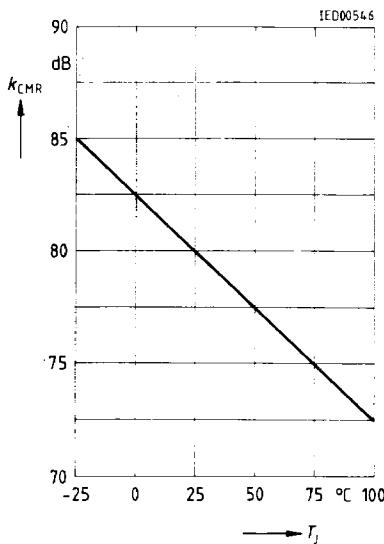
Phase Response versus Frequency

$T_j = 25^\circ\text{C}$; $V_S = \pm 10\text{ V}$

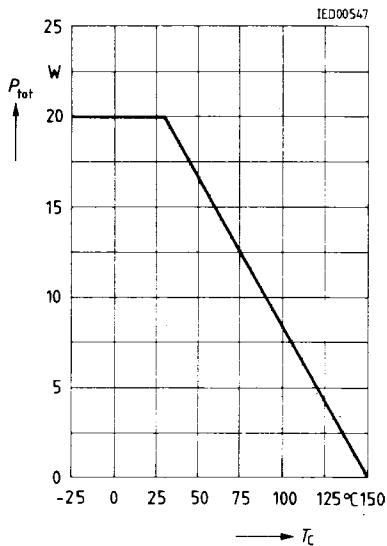


Common-Mode Rejection versus Junction Temperature

$V_S = \pm 10\text{ V}$



Max. Permissible Power Dissipation versus Case Temperature



Max. Permissible Power Dissipation versus Case Temperature

